

**Product data sheet** 

### **1. General description**

Planar passivated high commutation three quadrant triac in a TO3PF package intended for use in circuits where high static and dynamic dV/dt and high dl/dt can occur. This "series AT" triac will commutate the full RMS current at the maximum rated junction temperature ( $T_{j(max)}$  = 150 °C) without the aid of a snubber. It is used in applications where "high junction operating temperature capability" is required.

### 2. Features and benefits

- High current TRIAC
- 3Q technology for improved noise immunity
- · High commutation capability with maximum false trigger immunity
- High immunity to false turn-on by dV/dt
- High junction operating temperature capability (T<sub>i(max)</sub> = 150 °C)
- High voltage capability
- Least sensitive gate for highest noise immunity
- Low thermal resistance
- Planar passivated for voltage ruggedness and reliability
- Triggering in three quadrants only
- Insulated tab rated at 2500Vrms

#### 3. Applications

- Applications subject to high temperature (T<sub>j(max)</sub> = 150 °C)
- High current / high surge applications
- High power / industrial controls e.g. heating, motors, lighting

#### 4. Quick reference data

#### Table 1. Quick reference data

Symbol	Parameter	Conditions	Notes		Values	•	Unit
$V_{\text{DRM}}$	repetitive peak off-state voltage			1200			V
I <sub>T(RMS)</sub>	RMS on-state current	full sine wave; T <sub>h</sub> ≤ 77 °C; <u>Fig. 1; Fig. 2; Fig. 3</u>		40			A
I <sub>TSM</sub> non-repetitive peak on- state current		full sine wave; T <sub>j(init)</sub> = 25 °C; t <sub>p</sub> = 20 ms; <u>Fig. 4; Fig. 5</u>		400			A
		full sine wave; $T_{j(init)}$ = 25 °C; $t_p$ = 16.7 ms			440		А
Tj	operating junction temperature			-40 to 150		0	°C
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static ch	aracteristics		•				
I <sub>GT</sub>	gate trigger current	$V_{D} = 12 \text{ V}; \text{ I}_{T} = 0.1 \text{ A}; \text{ T2+ G+};$ T <sub>j</sub> = 25 °C; <u>Fig. 7</u>		-	-	75	mA
		$V_{D}$ = 12 V; I <sub>T</sub> = 0.1 A; T2+ G-; T <sub>j</sub> = 25 °C; Fig. 7		-	-	75	mA
		$V_{D}$ = 12 V; I <sub>T</sub> = 0.1 A; T2- G-; T <sub>j</sub> = 25 °C; Fig. 7		-	-	75	mA
I <sub>H</sub>	holding current	V <sub>D</sub> = 12 V; T <sub>i</sub> = 25 °C; <u>Fig. 9</u>		-	-	80	mA
чн	nording carroin						

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Dynamic	characteristics						
dV <sub>D</sub> /dt rate of rise of off-state voltage		$V_{DM} = 804 \text{ V}; \text{ T}_{\text{j}} = 125 \text{ °C}; (V_{DM} = 67\% \text{ of } V_{DRM});$ exponential waveform; gate open circuit		1500	-	-	V/µs
		$V_{DM}$ = 804 V; T <sub>j</sub> = 150 °C; (V <sub>DM</sub> = 67% of V <sub>DRM</sub> ); exponential waveform; gate open circuit		1000	-	-	V/µs
dl <sub>com</sub> /dt rate of change of commutating current		$V_D = 400 \text{ V}; \text{ T}_j = 125 \text{ °C}; \text{ I}_{T(RMS)} = 20 \text{ A};$ $dV_{com}/dt = 200 \text{ V}/\mu\text{s}; \text{ (snubberless condition); gate open circuit; Fig. 12}$		35	-	-	A/ms
		$V_{D} = 400 \text{ V}; \text{ T}_{j} = 125 \text{ °C}; \text{ I}_{T(RMS)} = 20 \text{ A};$ $dV_{com}/dt = 10 \text{ V}/\mu\text{s}; \text{ (snubberless condition); gate open circuit; Fig. 12}$		180		-	A/ms

## 5. Pinning information

#### Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	T1	main terminal 1		
2	T2	main terminal 2		T2-T1
3	G	gate		sym051
mb	n.c.	mounting base; isolated		Syllios I

## 6. Ordering information

Table 3. Ordering information							
Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date	
BTA440J-1200AT	TO3PF	BTA440J-1200ATQ	Tube	30	SOT1293	01-Mar-2017	

### 7. Marking

#### Table 4. Marking codes

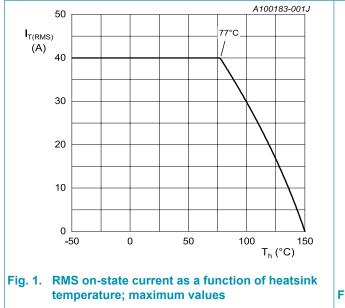
Type number	Marking codes		
	Assembly factory: A	Assembly factory: d	
BTA440J-1200AT	BTA440J 1200AT PJAxxxx xx	BTA440J 1200AT PJdxxxx xx	

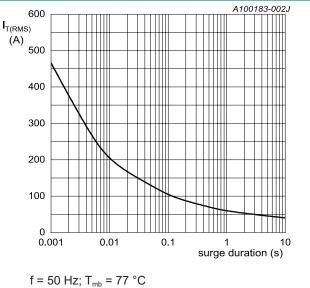
## 8. Limiting values

#### Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

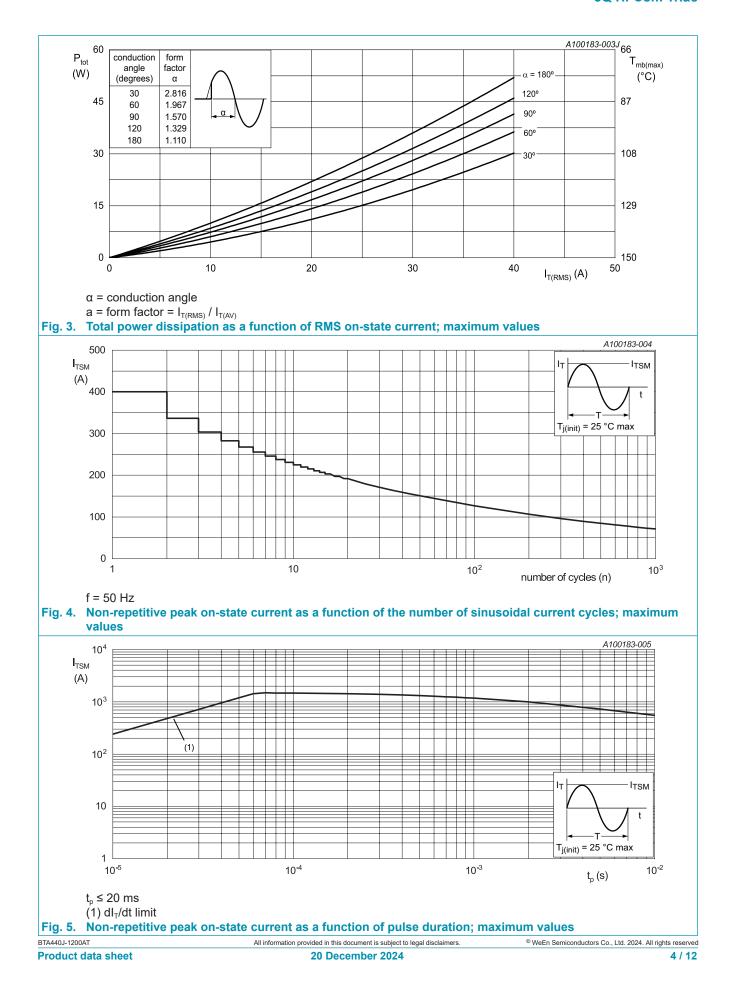
Symbol	Parameter	Conditions	Notes	Values	Unit
$V_{\text{DRM}}$	repetitive peak off-state voltage			1200	V
V <sub>RRM</sub>	repetitive peak reverse voltage			1200	V
$\mathbf{I}_{\mathrm{T(RMS)}}$	RMS on-state current	full sine wave; T <sub>h</sub> ≤ 77 °C; <u>Fig 1; Fig 2; Fig 3</u>		40	A
I <sub>TSM</sub>	non-repetitive peak on-state current	full sine wave; $T_{j(init)}$ = 25 °C; $t_p$ = 20 ms; Fig 4; Fig 5		400	A
		full sine wave; $T_{j(init)}$ = 25 °C; $t_p$ = 16.7 ms		440	А
l <sup>2</sup> t	l <sup>2</sup> t for fusing	t <sub>P</sub> = 10 ms; SIN		800	A <sup>2</sup> s
dl <sub>⊤</sub> /dt	rate of rise of on-state current	I <sub>G</sub> = 100 mA		150	A/µs
I <sub>GM</sub>	peak gate current			8	А
$P_{GM}$	peak gate power	t <sub>P</sub> = 25 us; T <sub>j(init)</sub> = 25 °C		40	W
$P_{G(AV)}$	average gate power	over any 20 ms period		1	W
T <sub>stg</sub>	storage temperature			-40 to 150	°C
Tj	operating junction temperature			-40 to 150	°C







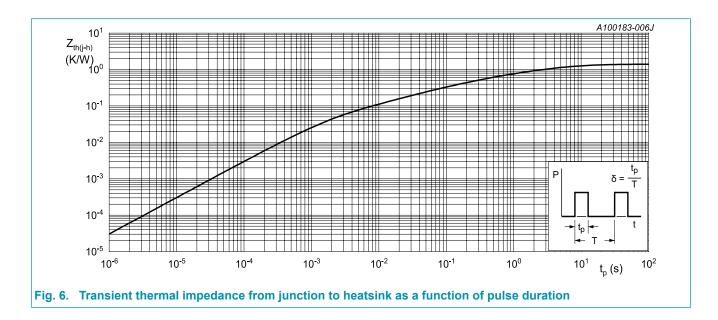
BTA440J-1200AT 3Q Hi-Com Triac



## 9. Thermal characteristics

#### Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Notes	Min	Тур	Мах	Unit
R <sub>th(j-h)</sub>	thermal resistance from junction to heatsink	full cycle; <u>Fig. 6</u>		-	-	1.4	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air		-	35	-	K/W



## **10. Isolation characteristics**

#### Table 7. Isolation characteristics

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
V <sub>isol(RMS)</sub>	RMS isolation voltage	from all pins to external heatsink; sinusoidal waveform; clean and dust free; $50 \text{ Hz} \le f \le 60 \text{ Hz}$ ; RH $\le 65 \%$ ; T <sub>mb</sub> = 25 °C		-	-	2500	V

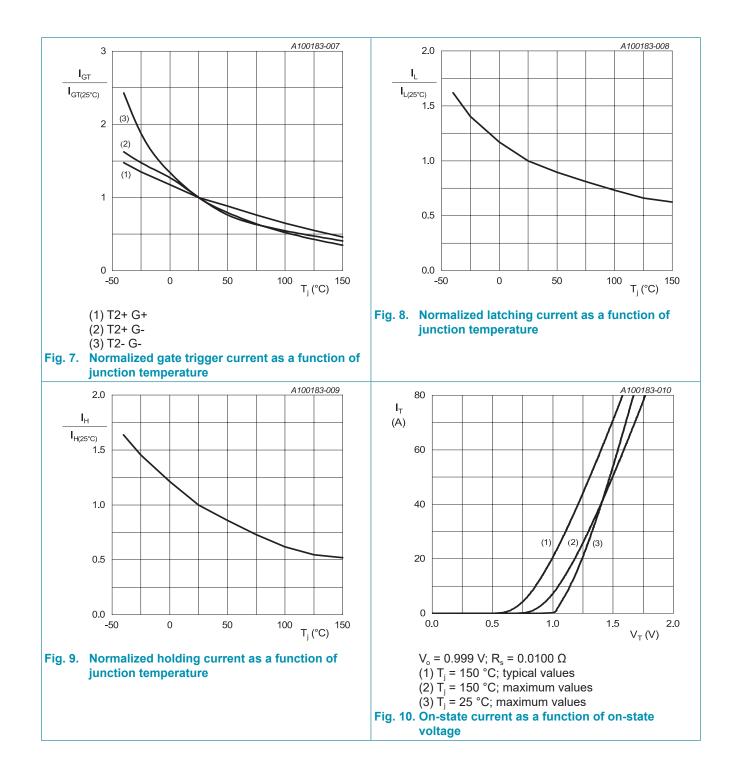
## **11. Characteristics**

Table 8. Characteristics

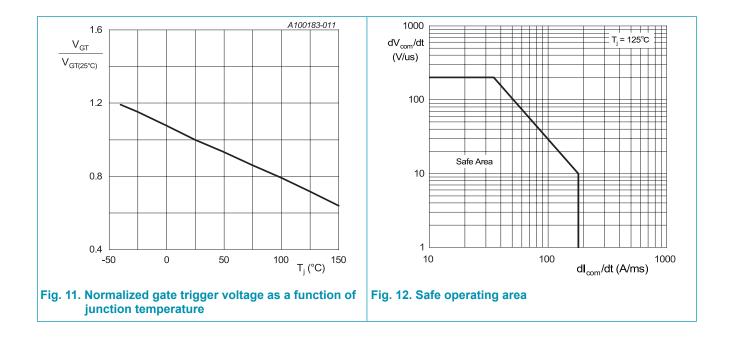
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static cha	aracteristics						
I <sub>GT</sub>	gate trigger current	$V_{\rm D}$ = 12 V; I <sub>T</sub> = 0.1 A; T2+ G+; T <sub>j</sub> = 25 °C; Fig. 7		-	-	75	mA
		$V_{D} = 12 \text{ V}; \text{ I}_{T} = 0.1 \text{ A}; \text{ T2+ G-};$ T <sub>j</sub> = 25 °C; <u>Fig. 7</u>		-	-	75	mA
		$V_{D} = 12 \text{ V}; \text{ I}_{T} = 0.1 \text{ A}; \text{ T2- G-};$ T <sub>j</sub> = 25 °C; <u>Fig. 7</u>		-	-	75	mA
IL	latching current	$V_{D} = 12 \text{ V}; \text{ I}_{G} = 0.1 \text{ A}; \text{ T2+ G+};$ T <sub>j</sub> = 25 °C; <u>Fig. 8</u>		-	-	100	mA
		V <sub>D</sub> = 12 V; I <sub>G</sub> = 0.1 A; T2+ G-; T <sub>j</sub> = 25 °C; <u>Fig. 8</u>		-	-	200	mA
		V <sub>D</sub> = 12 V; I <sub>G</sub> = 0.1 A; T2- G-; T <sub>j</sub> = 25 °C; Fig. 8		-	-	100	mA
I <sub>H</sub>	holding current	V <sub>D</sub> = 12 V; T <sub>j</sub> = 25 °C; <u>Fig. 9</u>		-	-	80	mA
V <sub>T</sub>	on-state voltage	I <sub>T</sub> = 40 A; T <sub>j</sub> = 25 °C; <u>Fig. 10</u>		-	-	1.4	V
V <sub>GT</sub>	gate trigger voltage	$V_{D} = 12 \text{ V}; \text{ I}_{T} = 0.1 \text{ A}; \text{ T}_{j} = 25 \text{ °C}; \text{ Fig. 11}$		-	-	1.2	V
		V <sub>D</sub> = 400 V; I <sub>T</sub> = 0.1 A; T <sub>j</sub> = 150 °C		0.3	-	-	V
I <sub>D</sub>	off-state current	V <sub>D</sub> = 1200 V; T <sub>j</sub> = 25 °C		-	-	10	μA
		V <sub>D</sub> = 1200 V; T <sub>j</sub> = 125 °C		-	-	2	mA
		V <sub>D</sub> = 1200 V; T <sub>j</sub> = 150 °C		-	-	5	mA
I <sub>R</sub>	reverse current	V <sub>R</sub> = 1200 V; T <sub>j</sub> = 25 °C		-	-	10	μA
		V <sub>R</sub> = 1200 V; T <sub>j</sub> = 125 °C		-	-	2	mA
		V <sub>R</sub> = 1200 V; T <sub>j</sub> = 150 °C		-	-	5	mA
Dynamic	characteristics						
dV <sub>D</sub> /dt	rate of rise of off-state voltage	$V_{DM}$ = 804 V; T <sub>j</sub> = 125 °C; (V <sub>DM</sub> = 67% of V <sub>DRM</sub> ); exponential waveform; gate open circuit		1500	-	-	V/µs
		$V_{DM}$ = 804 V; T <sub>j</sub> = 150 °C; (V <sub>DM</sub> = 67% of V <sub>DRM</sub> ); exponential waveform; gate open circuit		1000	-	-	V/µs
dl <sub>com</sub> /dt	rate of change of commutating current	$V_{D} = 400 \text{ V}; \text{ T}_{j} = 125 \text{ °C}; \text{ I}_{T(RMS)} = 20 \text{ A};$ $dV_{com}/dt = 200 \text{ V}/\mu\text{s}; \text{ (snubberless condition); gate open circuit; Fig. 12}$		35	-	-	A/ms
		$V_D = 400 \text{ V}; \text{ T}_j = 125 \text{ °C}; \text{ I}_{T(RMS)} = 20 \text{ A};$ $dV_{com}/dt = 10 \text{ V}/\mu\text{s}; \text{ (snubberless condition);}$ gate open circuit; <u>Fig. 12</u>		180		-	A/ms

BTA440J-1200AT

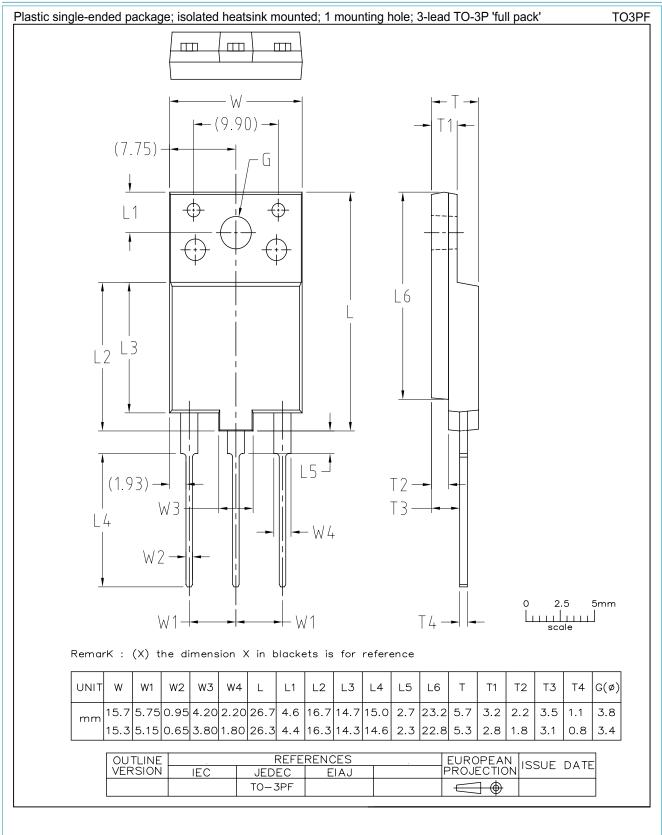
**3Q Hi-Com Triac** 



BTA440J-1200AT 3Q Hi-Com Triac



## 12. Package outline



#### BTA440J-1200AT 3Q Hi-Com Triac

## 13. Legal information

#### Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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